

<b>Notice of References Cited</b>	Application/Control No. 10/541,906	Applicant(s)/Patent Under Reexamination FINCH ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,706,989 A	12-1972	Taylor, Jr., John W.	342/94
*	B	US-3,745,571 A	07-1973	Chwastyk et al.	342/194
*	C	US-3,968,490 A	07-1976	Gostin, Judson J.	342/93
*	D	US-4,114,153 A	09-1978	Neidell, Norman S.	342/108
*	E	US-4,143,371 A	03-1979	Salvaudon et al.	342/94
*	F	US-4,463,356 A	07-1984	Short et al.	342/94
*	G	US-4,910,465 A	03-1990	Dillman, Richard F.	327/7
*	H	US-5,311,189 A	05-1994	Nagel, Dieter	342/95
*	I	US-5,457,462 A	10-1995	Mitsumoto et al.	342/93
*	J	US-5,818,383 A	10-1998	Stockburger et al.	342/109
*	K	US-6,067,041 A	05-2000	Kaiser et al.	342/171
*	L	US-2002/0196179 A1	12-2002	Mattox, Barry G.	342/194
*	M	US-6,894,638 B2	05-2005	Matsuda et al.	342/26R

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**NON-PATENT DOCUMENTS**

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,860,924 A	01-1975	Evans, Norol T.	342/94
*	B	US-4,308,536 A	12-1981	Sims et al.	342/70
*	C	US-RE31,509 E	01-1984	Neidell, Norman S.	342/108
*	D	US-4,809,002 A	02-1989	Togashi et al.	342/160
*	E	US-4,890,113 A	12-1989	Jacomini, Omar J.	342/163
*	F	US-5,081,459 A	01-1992	Guillerot et al.	342/90
*	G	US-5,117,698 A	06-1992	Baumoel, Joseph	73/861.28
*	H	US-5,231,402 A	07-1993	Ludloff et al.	342/192
*	I	US-2005/0179585 A1	08-2005	Walker et al.	342/134
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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